

TO SEPARATE, HOLD TOP AND BOTTOM EDGES, SNAP-APART AND RECARD CARBON

FORM PTO-892 (REV. 3-78)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		SERIAL NO. <div style="font-size: 1.2em; font-family: cursive;">151361</div>	GROUP/ART UNIT <div style="font-size: 1.2em; font-family: cursive;">258</div>	ATTACHMENT TO PAPER NUMBER	
NOTICE OF REFERENCES CITED				APPLICANT(S) <div style="font-size: 1.2em; font-family: cursive;">ASAHI NA</div>			

U.S. PATENT DOCUMENTS							
*	DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE	
A	4672419	1/9/87	McDavid	357 225	67S	1/25/84	
B	4761677	8/2/88	Sasaki	357	67R	1/22/87	
C	4725877	2/16/88	Brasen et al.	357	67R	4/11/86	
D	4593454	6/10/86	Baudrant et al.	357	67S	11/20/84	
E							
F							
G							
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I							
J							
K							

FOREIGN PATENT DOCUMENTS							
*	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUB-CLASS	PERTINENT SHTS. DWG. PP. SPEC.
L							
M							
N							
O							
P							
Q							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)	
R	IBM Technical Disclosure Bulletin, "Electromigration improvement of Al-Cu OR Au Conductors," Vol. 21 No. 12 May 1979, by J. K. Howard.
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EXAMINER <div style="font-size: 1.2em; font-family: cursive;">LOKE, H. Joy T.</div>	DATE <div style="font-size: 1.2em; font-family: cursive;">5/24/89</div> <div style="font-size: 1.2em; font-family: cursive;">4/12/89</div>	
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* A copy of this reference is not being furnished with this office action.
(See Manual of Patent Examining Procedure, section 707.05 (a).)